	/	Application/Control No.		Applicant(s)/Pat	Applicant(s)/Patent under Reexamination	ion
Issue Classification	· · · ·	10658380		LEE ET AL.		
	<u> "</u>	Examiner		Art Unit		
		Schindler, David		2862		
ORIG	ORIGINAL		INI	ERNATIONAL	INTERNATIONAL CLASSIFICATION	z
CLASS		SUBCLASS	CLAIMED	MED	NON-CLAIMED	VIMED
324	253		G 0 1 R	33 / 04		
CROSS REFERENCE(S)	FERENCE(S	(1				
CLASS SUBCLASS (0	SUBCLASS (ONE SUBCLASS	SS PER BLOCK)				
David M. Schindler 6/02/	6/02/2006	\			Total Claims Allowed:	Allowed:
(Assistant Examiner) (Date)	ite)	Malot	,		5	
(Legal Instruments Examiner) (Date)	·	EDWARD KEFKOWITZ  (PrimStyRERANISORY PATENT EXAMINE(Date)	MINE(Date)	20/2/	O.G. Print Claim(s) 1	O.G. Print Figure 2

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